ON-CHIP ELECTRONIC DEVICE AND METHOD FOR MANUFACTURING THE SAME

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Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 0 days.

Appl. No.: 13/484,865
Filed: May 31, 2012

Prior Publication Data

Related U.S. Application Data
Continuation-in-part of application No. 12/607,433, filed on Oct. 28, 2009, now Pat. No. 8,373,250.

Foreign Application Priority Data
Aug. 21, 2009 (TW) 98128200 A

Int. Cl.
H01L 27/08 (2006.01)
H01L 49/02 (2006.01)
H01L 23/522 (2006.01)
H01L 23/532 (2006.01)

U.S. Cl.
CPC 23/28/10 (2013.01); H01L 23/5227 (2013.01); H01L 23/5329 (2013.01)
USPC 257/531; 257/E29.323; 257/E29.022

Field of Classification Search
USPC 257/531, E29.323, E21.022
See application file for complete search history.

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ABSTRACT
The present invention relates to an on-chip electronic device and a method for manufacturing the same. The on-chip electronic device according to the present invention comprises a substrate, a porous layer, a plurality of magnetic bodies, and an electronic member layer. The porous layer is disposed on the substrate and has a plurality of voids; each of the plurality of magnetic bodies is disposed in the plurality of voids, respectively; and the electronic member layer is disposed on one side of the porous layer, such as upper side of or lower side of the porous layer. Because the plurality of magnetic bodies is used as the core of the inductance, the inductance is increased effectively and the area of the on-chip electronic device is reduced. Besides the manufacturing method according to the present invention is simple and compatible with the current CMOS process, the manufacturing cost can be lowered.

11 Claims, 15 Drawing Sheets
Figure 1

Figure 2
ON-CHIP ELECTRONIC DEVICE AND METHOD FOR MANUFACTURING THE SAME

REFERENCE TO RELATED APPLICATION

This Application is being filed as a Continuation-In-Part of patent application Ser. No. 12/607,433, filed 28 Oct. 2009, currently pending.

FIELD OF THE INVENTION

The present invention relates to a chip structure, and particularly to an on-chip electronic device and a method for manufacturing the same.

BACKGROUND OF THE INVENTION

With the progress of modern technologies, the coming of the information era, and the prosperous development of network, various electronic products are developed for satisfying people's demand. The functions of the electronic products are becoming powerful and complete increasingly, and thus bringing convenience for people's lives. All of the current electronic products pursue miniaturization and are fastidious about lightness and thinness. Under high-density packaging, the size of the required electronic devices is becoming relatively smaller, particularly for radio-frequency integrated circuits (RFICs) applied in portable wireless communication electronic products.

Currently, for increasingly demanded RFICs, the most urgent need is not on enhancing the efficiency of active devices but on improving the characteristics of passive devices such as resistors, capacitors, and inductors. For modern semiconductor process technologies, it is not a problem to provide superior resistors and capacitors that are easy to be implemented and simulated. However, for passive inductors, the only choice is spiral inductors. The inductance of spiral inductors depends strongly on the semiconductor process adopted to fabricate them. The method for increasing the inductance of an on-chip inductor is mostly to increase the number of turns of the inductor, which will increase the occupied area, and hence is unfavorable for miniaturization of the on-chip inductor. Thereby, how to increase effectively the inductance is still a major issue for developing the on-chip inductor. In addition, the Q factor (quality factor) of the inductor will also reduce owing to substrate loss.

Accordingly, the present invention provides an on-chip electronic device and a method for manufacturing the same for solving the problems described above. According to the present invention, the drawbacks according to the prior art as described above can be improved; the inductance can be increased; the area can be reduced; and the manufacturing cost can be lowered.

SUMMARY

An objective of the present invention is to provide an on-chip electronic device and a method for manufacturing the same, which has a simple structure with a manufacturing method compatible with the CMOS process, and hence reducing the cost.

Still another objective of the present invention is to provide an on-chip electronic device and a method for manufacturing the same, which has a high-intensity anisotropy magnetic field, and hence the magnetic resonance (MR) frequency is increased.

The on-chip electronic device according to the present invention comprises a substrate, a porous layer, a plurality of magnetic bodies, and an electronic member layer. The manufacturing method according to the present invention comprises providing the substrate, forming the porous layer with a plurality of voids on the substrate, forming the plurality of magnetic bodies in the plurality of voids, and forming the electronic member layer on the porous layer. Because the plurality of magnetic bodies is used as the core of the magnetic inductance, the inductance efficiency of the on-chip electronic device is increased effectively while the occupied area is reduced effectively. Besides, because the manufacturing method according to the present invention is compatible with the current CMOS process, the manufacturing cost can be lowered.

The manufacturing method according to the present invention further comprises providing the substrate, forming an electronic member layer on the substrate, forming a porous layer with a plurality of voids on the electronic member layer, and forming a plurality of magnetic bodies in the plurality of voids. Because the plurality of magnetic bodies is used as the core of the inductance efficiency, the inductance efficiency of the on-chip electronic device is increased effectively while the occupied area is reduced effectively.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 shows a structure of the on-chip electronic device according to a preferred embodiment of the present invention;
FIG. 2 shows a top view of the on-chip electronic device according to a preferred embodiment of the present invention;
FIG. 3A to FIG. 3H show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to a preferred embodiment of the present invention;
FIG. 4 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 5A to FIG. 5J show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 6 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 7 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 8 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 9A to FIG. 9I show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 10 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention;
FIG. 11A to FIG. 11J show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to another preferred embodiment of the present invention; and
FIG. 12 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention.

DETAILED DESCRIPTION

In order to make the structure and characteristics as well as the effectiveness of the present invention to be further understood and recognized, the detailed description of the present invention is provided as follows along with embodiments and accompanying figures.

FIG. 1 shows a structure of the on-chip electronic device according to a preferred embodiment of the present invention. As shown in the figure, the on-chip electronic device 10 according to the present invention is an inductor, which comprises a substrate 11, a porous layer 15, a plurality of magnetic bodies 153, and electronic member layer 18. The porous layer 15 is disposed on the substrate 11 and has a plurality of voids 151 thereon. The plurality of magnetic bodies 153 is disposed in the plurality of voids 151. A preferred embodiment of the porous layer 15 of the on-chip electronic device according to the present invention is a nonmetallic porous layer. The material of the magnetic bodies 153 can be any conductive material, such as ferromagnetic material, including nickel. The porous layer 15 according to the present invention is a nonconductor. A preferred embodiment of the porous layer 15 is, but not limited to, an aluminum oxide layer.

Because the porous layer 15 according to the present invention is nonconductive and voids 151 do not communicate with each other, the magnetic bodies 153 are isolated electrically from each other. A preferred embodiment of the conductor 153 according to the present invention is pillar formed. The depth-to-width ratio according to an embodiment of the conductor 153 is greater than 3:1. The geometry of the conductor 153 can be determined according to the thickness of the porous layer 15 and the diameter of the voids 151. The electronic member layer 18 is disposed on the porous layer 15. An embodiment of the electronic member layer 18 according to the present invention is an inductor member layer, such as a spiral inductor, which comprises a plurality of coils 181 and an interconnection wire 185. As shown in FIG. 2, the interconnection wire 185 is a crossover wire used for connecting to the innermost coil 181 of the electronic member layer 18 and crossing over other coils 181. According to an embodiment of the present invention, the shape of the electronic member layer 18 can be any geometrical shape, for example, a rectangle, an octagon, or a circle. The on-chip electronic device according to the present invention further comprises a first insulation layer 12 disposed on the substrate 11 and between the substrate 11 and the porous layer 15 for isolating electrically the substrate 11 and the porous layer 15, and a second insulation layer 16 disposed between the porous layer 15 and the electronic member layer 18.

According to the present invention, the porous layer 15 is disposed, and the plurality of magnetic bodies 153 is disposed in the plurality of voids 151 of the porous layer 15 to form a composite material as the core. Thereby, the inductance of the electronic member layer 18 is increased effectively. In comparison with the on-chip inductor according to the prior art, the on-chip electronic device performed as inductor according to the present invention can be reduced effectively the occupied chip area by the electronic member layer, and this achieving the objective of miniaturization. Additionally, the on-chip electronic device performed as inductor according to the present invention has a simple structure, and hence lowering the production cost.

FIG. 3A to FIG. 3H show structural schematic diagrams of the manufacturing process for the on-chip electronic device 10 according to a preferred embodiment of the present invention. First, as shown in FIG. 3A, the substrate 11 is provided and the first insulation layer 12 and the nonconductive layer 14 are formed on the substrate 11, and the nonconductive layer 14 is used for forming voids 151 in the nonconductive layer 14 and thus forming the porous layer 15 as shown in FIG. 3B. In addition, before the step of forming the porous layer 15, the first insulation layer 12 is firstly formed on the substrate 11 for isolating electrically the substrate 11 from the porous layer 15. Next, as shown in FIG. 3B, the voids 151 are formed in the nonconductive layer 14 for forming the porous layer 15. A preferred embodiment of the nonconductive layer 14 as described above is an aluminum oxide layer. Then, as shown in FIG. 3C, the magnetic bodies 153 are formed in the voids 151 for forming a composite material as the core. Afterwards, the subsequent step of forming the electronic member layer 18 on the porous layer 15 can be performed.

In the step of forming the nonconductive layer 14 described above, an aluminum layer is formed first. Then, oxidizing the aluminum layer forms the aluminum oxide layer, namely, the nonconductive layer. The above-mentioned method of forming the aluminum oxide layer as the nonconductive layer 14 is only an embodiment of the present invention. According to the present invention, evaporation deposition can be used for forming an aluminum layer on the substrate 11. Then the anodizing process can be used to oxidize the aluminum layer for forming the nonconductive layer 14. A method for fabricating the porous layer 15 according to the present invention is performing the anodizing process in various acid solutions on the aluminum layer. In the process, different specific parameters, such as applied voltage, current, temperature, and time, are controlled. These parameters have great correlation on the diameters and length of the plurality of voids 151. An embodiment of the present invention is to put the aluminum layer in a 0.3 M oxalic acid (H₂C₂O₄) solution and apply 40 volts to the aluminum layer at room temperature until the aluminum layer is oxidized completely. Then the aluminum oxide layer is formed as the nonconductive layer 14.

After the aluminum layer is oxidized completely, the aluminum oxide layer is annealed at 400°C for two hours for reinforcing its structure. Then, dispose the annealed nonconductive layer 14 in a 5% phosphoric acid (H₃PO₄) solution at 30°C for 50 minutes for forming uniformly distributed nanometer voids 151. The diameter of the plurality of voids 151 is 70 nm. Thereby, the porous layer 15 is formed. Next, form the magnetic bodies 153 in the plurality of voids 151. According to an embodiment of the present invention, immerse the porous layer 15 in tin chloride (SnCl₂) solution for two minutes and palladium chloride (PdCl₂) solution for 30 seconds, respectively, for activating the surface of the porous layer 15. Subsequently, electroplate nickel to the porous layer 15 at 60°C for one minute for forming the magnetic bodies 153 in the porous layer 15. The electroplating described above can be electroless plating. Afterwards, polish the surface of the porous layer 15 for removing nickel thereon for isolating electrically the magnetic bodies 153 (nickel) in the plurality of voids 151 of the porous layer 15, and thus reducing eddy current loss. Moreover, rapid thermal annealing can be further performed at 400°C for two minutes for improving magnetic characteristics of the magnetic bodies 153.
The method described above is only an embodiment of the present invention, not used for limiting the method for forming the porous layer 15. Beside, the material of the magnetic bodies 153 is not limited to nickel. Any other ferromagnetic material can be used as well. By using the porous layer 15 and the magnetic bodies 153 as the core, the strength of anisotropy magnetic field is high, and the material of the magnetic bodies 153 are made of a ferromagnetic material. Thus, the ferromagnetic resonance (FMR) frequency is increased.

After the porous layer 15 is completed, the process of forming the electronic member layer 18 can be performed subsequently. As shown in FIG. 3D, before forming the electronic member layer 18, the second insulation layer 16 is firstly formed on the porous layer 15 and between the porous layer 15 and the electronic member layer 18 for isolating electrically the porous layer 15 from the electronic member layer 18. According to the present invention, a method for forming the electronic member layer 18 is electroplating as described in detail as follows. Referring to FIG. 3D, a first seed layer 17 is formed first on the second insulation layer 16. Next, as shown in FIG. 3E, form a first photore sist layer 21 on the first seed layer 17 according to the desired pattern of the coils 181 of the electronic member layer 18 for masking part of the first seed layer 17. Then, a first metal layer is formed on the part of the first seed layers 17 not masked by the first photoresist layer 21. That is to say, the plurality of coils 181 of the electronic member layer 18 is formed on the first seed layer 17.

Next, as shown in FIG. 3F, remove the first photoresist layer 21 and form a second photoresist layer 22 on the first metal layer for masking the first metal layer, namely, the masking the coils 181. The pattern of the second photoresist layer 22 is bridge shaped for subsequently forming the interconnection wire 185, namely, forming the crossover of the electronic member layer 18 used for connecting to the innermost coil 181 of the electronic member layer 18 and crossing over the rest of the coils 181. Then, form a second seed layer 19 on the second photoresist layer 22 and form a third photoresist layer 23 on the second seed layer 19. However, the third photoresist 23 does not mask completely the second seed layer 19. Afterwards, referring to FIG. 3G, form a second metal layer on the second seed layer 19 not masked by the third photoresist layer 23 for forming the interconnection wire 185. Finally, referring to FIG. 3H, remove the second and third photoresist layers 22, 23, and the on-chip electronic device as shown in FIG. 11 is thereby completed. The materials of the first and second metal layers described above include copper. In other words, the materials of the coils of the electronic member layer 18 and of the interconnection wire 185 can be, but not limited to, copper. Additionally, the materials of the first and second seed layers 17, 19 include copper as well. Moreover, the material of the first seed layer 17 further includes titanium.

Furthermore, the magnetic bodies 153 of the on-chip electronic device 10a are made of a non-conductive material, such ceramic material, so the first and second insulation layers 12, 16 are not required. Therefore, the porous layer 15 having the magnetic bodies 153 is directly disposed on the substrate 11, and the electronic member layer 18 is directly disposed on the porous layer 15. On the other hand, the on-chip electronic device 10 is thinner without the first and second insulation layers 12, 16 while the magnetic bodies 153 are made of the non-conductive material.

Because the porous layer 15 is disposed on the substrate 11 and the magnetic bodies 153 are disposed in the voids 151 of the porous layer 15 for forming a composite material as the core, the inductance can be increased effectively while reduc-
The porous layer 25 has a plurality of voids 251 thereon, and a plurality of magnetic bodies 253 is disposed in the plurality of voids 251.

FIG. 7 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention. Being similar to FIG. 6, the on-chip electronic device 10c: according to this embodiment is also an inductor, so the on-chip electronic device 10c: also includes the substrate 11, the first insulating layer 12, the porous layer 15, the plurality of magnetic bodies 153, the second insulating layer 16, and the electronic member layer 18. However, the electronic member layer 18 is disposed on the porous layer 15c and the porous layer 15b having the plurality of voids 151 thereon according to this embodiment is not disposed on the substrate 11. The electronic member layer 18 is disposed on the substrate 11, and the porous layer 15 is disposed on the first insulating layer 12 having the coil spacer layer 187 covered with the coils 181 and the wire 185. The plurality of magnetic bodies 153 is disposed in the plurality of voids 151.

Further, the first insulating layer 12 is disposed between the substrate 11 and the electronic member layer 18, and the second insulating layer 16 is disposed between the electronic member layer 18 and the porous layer 15c. FIG. 8 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention. The on-chip electronic device 30 shown in FIG. 8 is a resonator, and the on-chip electronic device 30 is similar to the on-chip electronic device 10c. Therefore, the on-chip electronic device 30 also comprises the substrate 11, the first insulating layer 12, the second insulating layer 16, and the electronic member layer 18, the on-chip electronic device 30 further has a porous layer 15a and a plurality of magnetic bodies 153a, wherein the porous layer 15a is disposed on the substrate 11, and the first insulating layer 12 is disposed between the substrate 11 and the porous layer 15a. The porous layer 15a also has a plurality of voids 151a, and the plurality of magnetic bodies 153a is also disposed in the voids. The porous layer 15a according to this embodiment is shorter than the substrate 11, and shorter than the first insulating layer 12.

Further, a spacer layer 157 is located on the first insulating layer 12 and disposed around the porous layer 15a. The electronic member layer 18 is disposed on the porous layer 15a, and further disposed on the spacer layer 157. The metal layer 18 also has the coils 181 and the wire 185, and the wire 185 is also used to connect with the innermost coil 181 and other coils 181. It is noted that a chamber 155 is disposed between the porous layer 15a and the electronic member layer 18. Accordingly, the on-chip electronic device 30 provides the resonator characteristics due to that the porous layer 15a, the electronic member layer 18, and the first insulating layer 12 is formed as a resonant structure.

FIG. 9A to FIG. 9B show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to another preferred embodiment of the present invention. Firstly, as shown in FIG. 9A, the substrate 11 is provided and the first insulating layer 12 and the non-conductive layer 14 are formed on the substrate 11, and the nonconductive layer 14 is used for forming voids 151a in the nonconductive layer 14 and thus disposing the porous layer 15a on the first insulating layer 12 as shown in FIG. 9B. A preferred embodiment of the nonconductive layer 14 as described above is an aluminum oxide layer. It is noted that the non-conductive layer 14 is shorter than the substrate 11 and the first insulating layer 12, so the porous layer 15a occupies part of upper surface of the first insulating layer 12. Then, as shown in FIG. 9C, the magnetic bodies 153a are formed in the voids 151a for forming a composite material as the filled core of the voids 151a.

As shown in FIG. 9D, the spacer layer 157 is formed on the porous layer 15a and the first insulating layer 12. That is, the spacer layer 157 covers the porous layer 15a and the first insulating layer 12. Next, as shown in FIG. 9E, a first photoresist layer 21 is formed on the spacer layer 157 according to the desired pattern of the coils 181 of the electronic member layer 18 for masking part of the spacer layer 157. Thereby, the electronic member layer 18 is disposed on the spacer layer 157, so the electronic member layer 18 is also disposed on the porous layer 15a. Then, as shown in FIG. 9F, the chamber 155 is formed between the porous layer 15a and the electronic member layer 18. On the other hand, the chamber 155 is formed in the spacer layer 157.

Next, the steps as shown in FIGS. 9G-9I are the same as the steps as shown in FIGS. 3F-3H, so steps as shown in FIGS. 9G-9I have described above steps as shown in FIGS. 3F-3H.

FIG. 10 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention. The on-chip electronic device 30a shown in FIG. 10 is a resonator, and the on-chip electronic device 30a is similar to the on-chip electronic device 30. Therefore, the on-chip electronic device 30a also comprises the substrate 11, the first insulating layer 12, the porous layer 15a, the plurality of magnetic bodies 153a, the second insulating layer 16, and the electronic member layer 18.

The electronic member layer 18 is disposed on the substrate 11, and the first insulating layer 12 is disposed between the substrate 11 and the electronic member layer 18. The porous layer 15 according to this embodiment is also shorter than the substrate 11, and shorter than the electronic member layer 18. The porous layer 15a is disposed on the electronic member layer 18. It is noted that a metal layer 28 is further disposed between the porous layer 15a and the electronic member layer 18, and a chamber 155 is also disposed between the porous layer 15a and the electronic member layer 18, wherein the metal layer 28 can set as a beam, an anchor or a bridge. A gap d is aligned between the porous layer 15a and the metal layer 28. Thereby, the metal layer 28 is oscillated while the on-chip electronic device is applied with power. Further, a spacer layer 159 is located on the electronic member layer 18 and disposed around the porous layer 15a and the metal layer 28. Furthermore, a holding layer 29 is disposed on the porous layer 15a and the spacers 159, and holding the porous layer 15a.

FIG. 11A to FIG. 11J show structural schematic diagrams of the manufacturing process for the on-chip electronic device according to another preferred embodiment of the present invention. Firstly, as shown in FIG. 11A, the substrate 11 is provided and the first insulating layer 12 is formed on the substrate 11. Next, as shown in FIG. 11B, the first photoresist layer 21 is formed on the first insulating layer 12 according to the desired pattern of the coils 181 of the electronic member layer 18 for masking part of the first insulating layer 12. Thereby, the electronic member layer 18 is disposed on the first insulating layer 12, so the electronic member layer 18 is also disposed on the first insulating layer 12. The steps as shown in FIGS. 11C-11D are the same as the steps as shown in the FIGS. 9G-9H, so the embodiment of the steps as shown in FIGS. 11C-11D are not repeated.

Next, as shown in FIG. 11E, the electronic member layer 18 is covered with a coil spacer layer 187 for flat and smooth. Then, a metal layer 28 is disposed on the electronic member layer 18, and the spacer layer 187 is disposed on the electronic member layer 18 and the metal layer 28 as shown in FIG. 11F. As shown in FIG. 11G, a fillister 159a is formed on the coil...
spacer layer 159 for forming the porous layer 15a as shown in FIG. 11 H. Then, as shown in FIG. 11 H, the porous layer 15a with the plurality of voids 151 are formed in the fillister 159a, and the magnetic bodies are filled in the voids respectively. Therefore, the porous layer 15a is disposed on the upper side of the electronic member layer 18. Next, as shown in FIG. 11 I, the holding layer 29 is disposed on the porous layer 15a and the spacer layer 159, so the porous layer 15a is disposed between the electronic member layer 18 and the holding layer 29. As shown in FIG. 11 I, the chamber 155 is formed in the spacer layer 159, so the chamber 155 is disposed between the porous layer 15a and the electronic member layer 18. Thus, the on-chip electronic device 30a performed as the resonator is completed.

FIG. 12 shows a structure of the on-chip electronic device according to another preferred embodiment of the present invention. The on-chip electronic device 30b shown in FIG. 12 is a resonator, and is similar to the on-chip electronic device 30a shown in FIG. 10. Therefore, the on-chip electronic device 30b also comprises the substrate 11, the first insulating layer 12, the porous layer 15a, the plurality of magnetic bodies 153a, the second insulating layer 16, and the electronic member layer 18.

The electronic member layer 18 is disposed on the substrate 11 and the first insulating layer 12 is disposed between the substrate 11 and the electronic member layer 18. The spacer layer 159 is located on the electronic member layer 18. The metal layer 28 is disposed on the electronic member layer 18, and the holding layer 29 is disposed on the metal layer 28 and the spacer layer 159. The porous layer 15a is disposed on the holding layer 29. The chamber 155 is disposed between the metal layer 28 and the holding layer 29, that means the chamber 155 is also disposed between the porous layer 15a and the electronic member layer 18 while the metal layer 28 is disposed on the electronic member layer 18 and the porous layer 15a is disposed on the holding layer 29. Further, the spacer layer 159 are disposed around the porous layer 15a.

To sum up, the on-chip electronic device according to the present invention comprises providing a substrate, forming a porous layer with a plurality of voids on the substrate, forming a plurality of magnetic bodies isolated from each other in the plurality of voids, and forming an inductor on the porous layer. Because the plurality of magnetic bodies is used as the core of the electronic member layer, the inductance of the on-chip electronic device is increased effectively and still increases at high frequencies. Such on-chip electronic device according to the present invention can be performed as an on-chip inductor or an on-chip resonator. Thereby, the area occupied by the on-chip electronic device is reduced effectively, which is beneficial for miniaturization. Besides, because the manufacturing method according to the present invention is compatible with the current CMOS process, the manufacturing cost can be lowered.

Accordingly, the present invention conforms to the legal requirements owing to its novelty, nonobviousness, and utility. However, the foregoing description is only embodiments of the present invention, not used to limit the scope and range of the present invention. Those equivalent changes or modifications made according to the shape, structure, feature, or spirit described in the claims of the present invention are included in the appended claims of the present invention.

The invention claimed is:

1. An on-chip electronic device, comprising: a substrate; a porous layer, disposed on said substrate, and having a plurality of nanometer voids; a plurality of magnetic bodies, disposed in said plurality of nanometer voids; and an electronic member layer, disposed on one side of said porous layer; wherein said electronic member layer is disposed on the lower side of said porous layer, and further comprising a beam layer, disposed between said electronic member layer and said porous layer.

2. The on-chip electronic device of claim 1, wherein said electronic member layer is an inductor member layer or a resonator member layer.

3. The on-chip electronic device of claim 1, wherein said electronic member layer is disposed on the upper side of said porous layer, and further comprising:
   a first insulation layer, disposed between said substrate and said porous layer; and
   a second insulation layer, disposed between said porous layer and said electronic member layer.

4. The on-chip electronic device of claim 1, wherein said electronic member layer is disposed on the upper side of said porous layer, and further comprising a chamber disposed in said substrate.

5. The on-chip electronic device of claim 1, wherein said electronic member layer is disposed on the upper side of said porous layer, and further comprising a chamber disposed between said porous layer and said electronic member layer.

6. The on-chip electronic device of claim 1, wherein said metal coil is disposed on the lower side of said porous layer, and further comprising:
   a first insulation layer, disposed between said substrate and said electronic member layer; and
   a second insulation layer, disposed between said electronic member layer and said porous layer.

7. The on-chip electronic device of claim 1, wherein said electronic member layer is disposed on the lower side of said porous layer, and further comprising a chamber disposed between said electronic member layer and said porous layer.

8. The on-chip electronic device of claim 1, wherein said electronic member layer is disposed on the lower side of said porous layer, and further comprising a beam layer disposed on the upper side of said electronic member layer.

9. The on-chip electronic device of claim 1, wherein the material of said plurality of magnetic bodies is a conductive material or a non-conductive material.

10. The on-chip electronic device of claim 1, wherein said magnetic bodies are pillar shaped.

11. The on-chip electronic device of claim 1, wherein the depth-to-width ratio of said magnetic bodies is greater than 3:1.